

October 2007 UniFETTM

FDP52N20 / FDPF52N20T

N-Channel MOSFET 200V, 52A, 0.049 Ω

Features

- $R_{DS(on)} = 0.041\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 26A$
- Low gate charge (Typ. 49nC)
- Low C_{rss} (Typ. 66pF)
- · Fast switching
- 100% avalanche tested
- · Improve dv/dt capability
- · RoHS compliant



Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advance technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switching mode power supplies and active power factor correction.



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol		Parameter		FDP52N20	FDPF52N20T	Units	
V_{DSS}	Drain to Source Voltage	Drain to Source Voltage			200		
V_{GSS}	Gate to Source Voltage			±	<u>:</u> 30	V	
	DrainCurrent	-Continuous (T _C = 25°C)		52	52*	Α	
ID	Diamounent	-Continuous (T _C = 100°C)		33	33*	A	
I _{DM}	Drain Current	(Note 1)	208	208*	Α		
E _{AS}	Single Pulsed Avalanche Energy (Not			2520		mJ	
I _{AR}	Avalanche Current	(Note 1)	52		Α		
E _{AR}	Repetitive Avalanche Energy		(Note 1)	35.7		mJ	
dv/dt	Peak Diode Recovery dv/dt		(Note 3)	4.5		V/ns	
D	Dower Dissination	$(T_C = 25^{\circ}C)$		357	38.5	W	
P_{D}	Power Dissipation - Derate above 25°C		2.86	0.3	W/°C		
T _J , T _{STG}	Operating and Storage Temperature Range			-55 t	o +150	οС	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			3	300	°C	

^{*}Drain current limited by maximum junction temperature

Thermal Characteristics

Symbol	Parameter	FDP52N20	FDPF52N20T	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case 0.3		3.3	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ. 0.5 -		°C/W	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

Package Marking and Ordering Information $T_C = 25^{\circ}C$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDP52N20	FDP52N20	TO-220	-	-	50
FDPF52N20T	FDPF52N20T	TO-220F	-	-	50

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Off Charac	cteristics					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V, T_J = 25^{\circ} C$	200	-	-	V
ΔBV _{DSS} / ΔΤ _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.2	-	V/°C
1	Zero Gate Voltage Drain Current	$V_{DS} = 200V, V_{GS} = 0V$	-	-	1	μА
IDSS	Zero Gate voltage Drain Current	$V_{DS} = 160V, T_{C} = 125^{\circ}C$	-	-	10	μΑ
I _{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30V, V_{DS} = 0V$	-	-	±100	nA

On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	3.0	-	5.0	V
R _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = 10V, I_D = 26A$	-	0.041	0.049	Ω
g _{ES}	Forward Transconductance	$V_{DS} = 40V, I_D = 26A$ (Not	e 4) -	35	-	S

Dynamic Characteristics

C _{iss}	Input Capacitance	V 05V V 0V		-	2230	2900	pF
C _{oss}	Output Capacitance	$V_{DS} = 25V, V_{GS} = 0V$		-	540	700	pF
C _{rss}	Reverse Transfer Capacitance	1 - 11/11/12	Ī	-	66	100	pF
Q _{g(tot)}	Total Gate Charge at 10V			-	49	63	nC
Q _{gs}	Gate to Source Gate Charge	$V_{DS} = 160V, I_{D} = 52A$		-	19	-	nC
Q _{gd}	Gate to Drain "Miller" Charge	V _{GS} = 10V	(Note 4, 5)	-	24	-	nC

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	53	115	ns
t _r	Turn-On Rise Time	$V_{DD} = 100V, I_{D} = 20A$	-	175	359	ns
t _{d(off)}	Turn-Off Delay Time	$R_G = 25\Omega$	-	48	107	ns
t _f	Turn-Off Fall Time	(Note 4, 5)	-	29	68	ns

Drain-Source Diode Characteristics

I _S	Maximum Continuous Drain to Source Diode Forward Current			=	-	52	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	204	Α	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0V, I_{SD} = 52A$		-	-	1.5	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, I _{SD} = 52A		-	162	-	ns
Q _{rr}	Reverse Recovery Charge	$dI_F/dt = 100A/\mu s$	(Note 4)	-	1.3	-	μС

- Notes:

 1. Repetitive Rating: Pulse width limited by maximum junction temperature
- 2. L = 1.4mH, I $_{AS}$ = 52A, V $_{DD}$ = 50V, R $_{G}$ = 25 $\!\Omega$, Starting T $_{J}$ = 25°C
- 3. $I_{SD} \le 52 A$, di/dt $\le 200 A/\mu s$, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$
- 4. Pulse Test: Pulse width $\leq 300 \mu s, \ Duty \ Cycle \leq 2\%$
- 5. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

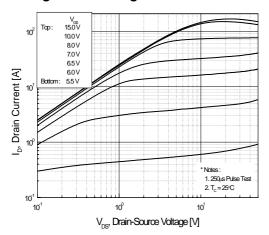


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

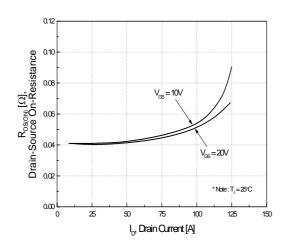


Figure 5. Capacitance Characteristics

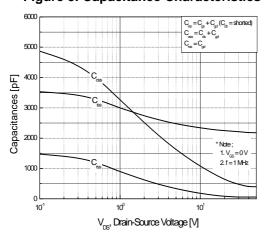


Figure 2. Transfer Characteristics

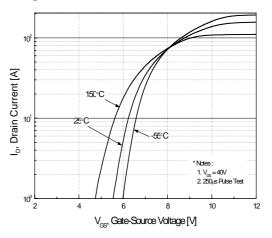


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

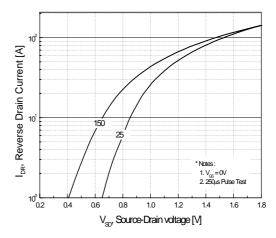
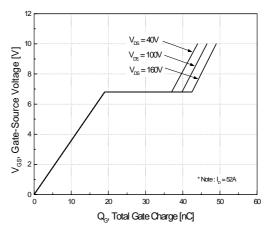


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

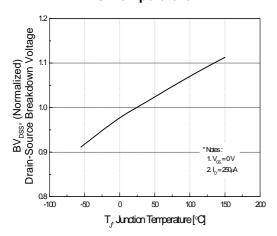


Figure 9-1. Maximum Safe Operating Area - FDP52N20

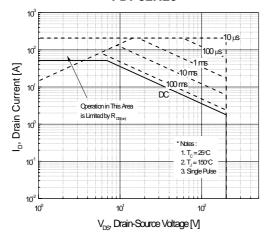


Figure 10. Maximum Drain Current

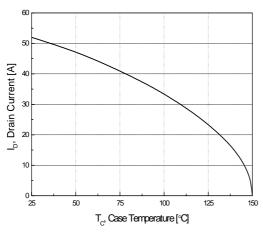


Figure 8. On-Resistance Variation vs. Temperature

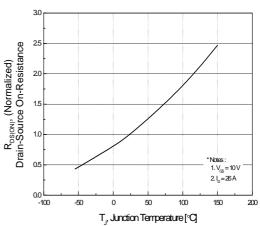
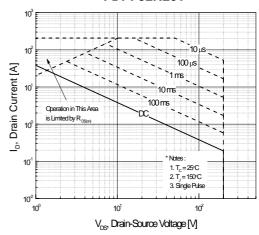


Figure 9-2. Maximum Safe Operating Area - FDPF52N20T



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Typical Performance Characteristics (Continued)

Figure 11-1. Transient Thermal Response Curve - FDP52N20

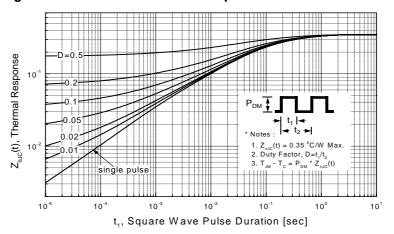
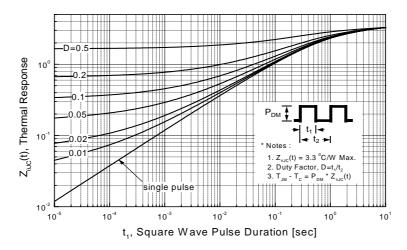
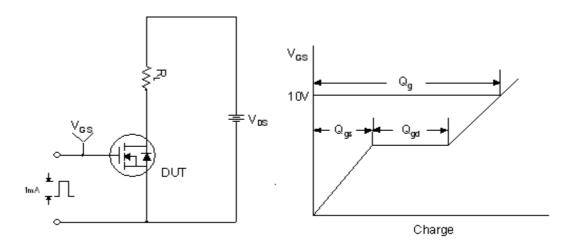


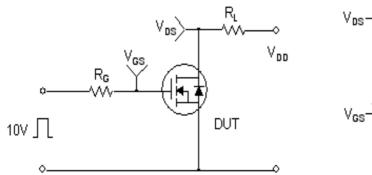
Figure 11-2. Transient Thermal Response Curve - FDPF52N20T

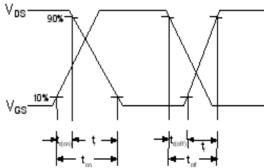


Gate Charge Test Circuit & Waveform

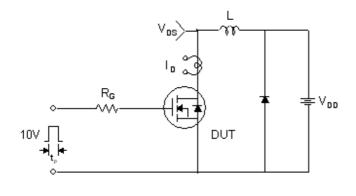


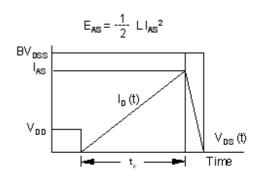
Resistive Switching Test Circuit & Waveforms



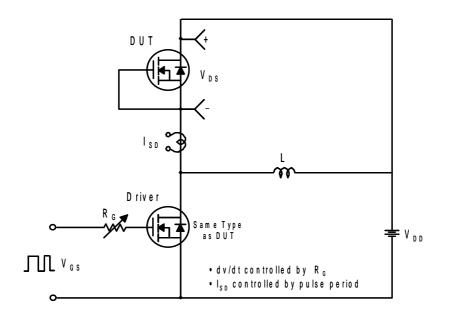


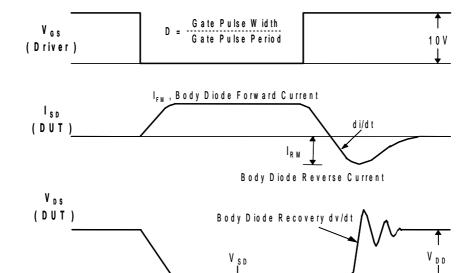
Unclamped Inductive Switching Test Circuit & Waveforms





Peak Diode Recovery dv/dt Test Circuit & Waveforms

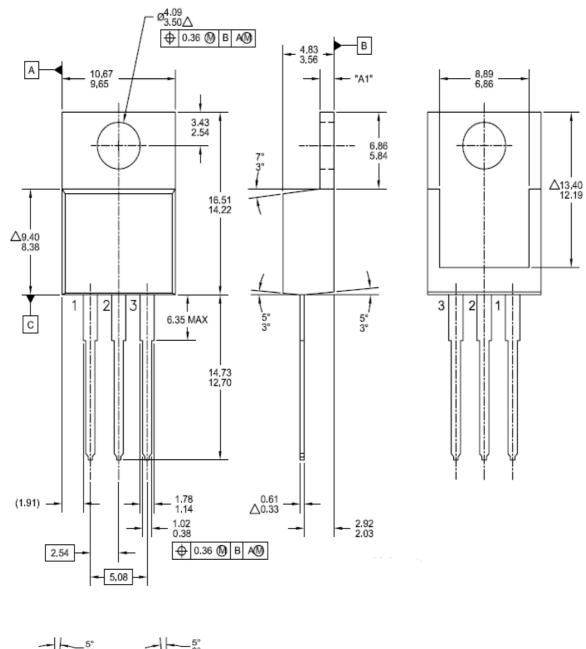


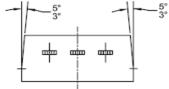


Body Diode Forward Voltage Drop

Mechanical Dimensions

TO - 220

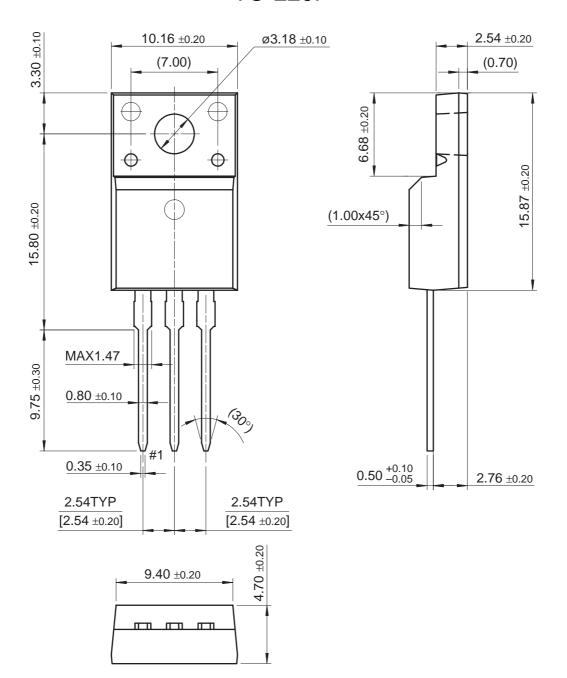




Dimensions in Millimeters

Mechanical Dimensions

TO-220F



Dimensions in Millimeters





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